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Effect of Statistical Counting Errors on Wavelength Criteria for X-Ray Spectra^{*}

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Various features of the spectral profile of an x-ray line can be measured with an uncertainty which is only a small fraction of the observed line width. With recent improvements in measurement techniques, statistical errors due to the random fluctuations of the intensities in counter recordings may become significant. The present study considers the effect of such errors on several features of the line profile which could be used for definition of its wavelength. These may be broadly classified into three groups, viz, the peak, the centroid, and the median. In the present analysis the statistical errors associated with these features are compared theoretically, with the assumption of negligible error in angular measurement. Certain systematic errors are also briefly examined. The effects of truncation range, asymmetry, and background intensity are considered, as well as possible optimization of the data-taking procedure.

In general, σ , the standard deviation of the wavelength, is given by $\sigma/W = F/(I_pT)^{1/2}$, where W is the full width at half-maximum intensity, I_p the peak intensity, T the total counting time, and F a dimensionless factor of the order of unity. Thus F may be regarded as a factor of merit for comparing the various cases, a low value of F being desirable. When the form of the line profile is known a priori, it is usually best to make use of this knowledge; e.g., a Lorentzian can be thus fitted with $F \approx 0.8$ for any of the three wavelength features. Using optimized truncation ranges and including the error in locating end points, one obtains approximately this same F for the centroid or median even without prior knowledge of the profile. In the latter case the value of F for the peak usually ranges from about 1.6 to 2.1. However, the peak is less subject to certain systematic errors and is preferable from the viewpoint of simplicity and historical precedent. It is recommended that use of the peak be continued at present; further study of the problem from the viewpoint of atomic energy level interpretation would be desirable.

Key Words: Lattice constants, peak intensity, physical constants, spectral line profiles, statistical error analysis, x-ray line shapes, x-ray spectra, x-ray wavelength criteria.

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1. Introduction

1.1. Problem of Wavelength Criterion

X-ray emission lines have natural widths of the order of 0.1 percent of their wavelengths and in many cases show considerable asymmetry in their line profiles [1].³ Precision wavelength measurements [2,3] have frequently claimed accuracies of a few parts per million; in a recent paper by Bearden and coworkers [4] probable errors of approximately one part per million were reported for five standard reference lines. Since the error estimate is thus only a fraction of 1 percent of the line width, it is clearly necessary to use some specific feature of the line profile in defining the wavelength. For symmetric lines all criteria which are likely to be regarded as reasonable definitions will reduce to the same value; in the more general case of asymmetric lines, the resulting values may differ appreciably.

These wavelengths are vitally important both in determining atomic energy levels and in providing standards for crystallography and γ -ray spectroscopy. Hence at least four factors should be considered in formulating a wavelength criterion, viz:

- 1. Consistency of the resulting energy level scheme with the Ritz combination principle, i.e., the atomic interpretation.
- 2. Simplicity of the definition.
- 3. Historical precedents and current usage.
- 4. Attainable accuracy as limited by the effects of both systematic and statistical errors.

While the first factor is clearly the one of most fundamental physical significance, presently available experimental data and theoretical knowledge of x-ray line shapes do not appear to provide a clear answer to this point. From the standpoint of simplicity and intuitive appeal the peak of the line profile is probably the most acceptable criterion. This is also generally supported by current usage in x-ray spectroscopy, as well as considerable historical precedent.

The majority of tabulated x-ray emission wavelengths were recorded with photographic plates. Usually it was not stated just what point on the profile defined wavelength, although this probably corresponded, at least approximately, to the position of maximum blackening. In some cases a microdensitometer trace of the plates was made and the maximum used to specify wavelength.

Most recent high precision determinations measure the peak of a line by rotating a crystal through small angular increments and recording the intensity at each step by means of a photon counter (gas or scintillation counter), yielding a step-by-step scan of the line profile. This basic method has been used with single-crystal [4], double-crystal [4], and curved-crystal [5] spectrometers. High angular accuracy has long been attainable; the recent development of an angular interferometer [6] has furnished a new precise and convenient technique to facilitate the required angular measurements. The accuracy of a wavelength measurement is limited by both systematic and statistical errors. Systematic errors may arise from numerous causes, e.g., drift in x-ray tube voltage, presence of satellites, and distortion due to the instrumental "window." While this window may be the predominant factor in crystallography and γ -ray spectroscopy, it is much less serious in x-ray spectroscopic work.

With good crystals and proper geometry, such distortion of the true line profile may be held to a minimum. For example, using two good quartz crystals with the Mo K α_1 line in second order, Bearden [4] obtained a window curve which was only about 3 percent of the natural line width. Brogren [7] reported a comparably narrow window with the Cu K α_1 line. Moreover, Bonse and Hart [8] recently reported almost tailless x-ray rocking curves obtained by multiple Bragg reflections between the walls of grooves cut into large perfect crystals of silicon and germanium. Furthermore, one may remove much of the residual instrumental distortion by "unfolding techniques" [9]; Sauder [10] has given a somewhat simplified method of correcting selected features of the line profile.

The statistical error is largely due to random intensity fluctuations, caused by the inherent nature of the photon emission from the x-ray target and by the properties of the counter. The present paper is principally concerned with this factor as it affects the various features used to define wavelength. It also treats briefly certain sources of systematic error which are sensitive to the choice of wavelength criterion.

Thomsen [11] has given a preliminary analysis of the problem and indicated how the errors may often be reduced by varying the counting times for different points on the line profile. Subsequently Wilson, Thomsen, and Yap [12] generalized this optimization procedure. The overall problem has been comprehensively treated in a thesis by Yap [13], which forms the basis for the present paper.

This treatment will consider at length three features of the line profile, viz, the centroid, the median, and the peak. To date the peak has been used almost exclusively in x-ray spectroscopy whenever a defining feature was explicitly specified. Some crystallographers [14] and γ -ray spectroscopists [15] have employed the centroid and the median in a limited number of cases.

The greater mathematical simplicity of the centroid and median facilitates a more straightforward and complete analysis; hence we will treat them first. Both offer the possibility of a limited improvement in the statistical error. However, we finally recommend continued use of the peak, primarily because of its simplicity and its current acceptance. The statistical error of the peak is treated at length in section 5, which is independent of the analysis of the centroid and median in sections 3 and 4.

1.2. Previous Investigations

Other investigators have studied various aspects of the problem. Pike and Wilson [16] derived the statis-

³ Figures in brackets indicate the literature references at the end of this paper.

tical error of the centroid; Parrish [14] and his coworkers studied, both theoretically and experimentally, the use of the centroid for lattice parameter measurements, including the effect of truncation error. Merrill and DuMond [17] analyzed the problem of fitting a Lorentzian to the data points by least squares and outlined a method for obtaining the resulting statistical error of the peak. Previously Muller, Hoyt, Klein, and DuMond [18] had derived an expression for the statistical error that arises in fitting any assumed profile to the data and applied this result to the case of an isosceles triangle. Knowles [19] obtained an approximate expression for the statistical error of the median.

Several workers have made comparative studies of various features. Cohen and DuMond [20] discussed the relative merits of the centroid and the peak, and recommended the use of the latter. The same conclusion was reached earlier by Porteus and Parratt [21] in an unpublished investigation. Wilson [22] analyzed both the statistical and the systematic errors that result from locating the peak by a least-squares parabolic fit to the data and by finding the midpoint of a horizontal chord. Beu and Scott [23] discussed reasons for preferring the peak to the centroid for lattice parameter measurements. Recently Bačkovsky [24] compared several features, including the peak and the midpoint of a horizontal chord, and suggested using the latter, with the chord drawn near the inflection point of the line profile.

1.3. Profile Features for Wavelength Criteria

a. The Centroid. In the present analysis we will define the centroid x_c as the center of mass of some specified truncated portion of the line profile, i.e.,

$$x_{c} = \int_{X_{1}}^{X_{2}} x I(x) dx \Big/ \int_{X_{1}}^{X_{2}} I(x) dx, \qquad (1.1)$$

where I(x) represents the true intensity and X_1 and X_2 the selected truncation limits. In principle, the abscissa variable x should represent wavelength; however, x-ray lines are sufficiently narrow so that an angle or an energy scale may be employed with negligible error.

It should be noted that crystallographers [14] who have employed the centroid have always assumed an infinite range in the above *definition* (which is essential in order to apply the convolution theorem for addition of centroids). Experimentally it was, of course, necessary to infer the centroid value by extrapolation from a finite truncated portion of the curve. By contrast the present paper considers the possibility of *defining* the centroid with *finite truncation limits*, which represents a generalized concept.

b. The Median. Similarly we will define the median as that value x_m which equally divides some specified portion of the line profile, i.e.,

$$\int_{X_1}^{X_m} I(x) dx = \int_{X_m}^{X_2} I(x) dx.$$
(1.2)

c. The Peak. Finally we will define the peak simply as the abscissa x_p corresponding to the maximum intensity. (In this connection we will disregard the possibility of multiple peaks.) In practice two primary techniques have been used to locate this feature; the results so obtained will be termed (i) the geometrical peak and (ii) the extrapolated peak.

(i) The Geometrical Peak. A smooth curve may be fitted to the raw data points by a computer (using either a theoretical line profile or an empirical function with undetermined parameters) or drawn in graphically. The geometrical peak x_p is then defined as the abscissa value for which the maximum occurs, i.e.,

$$[dI(x)/dx]_{x=x_p} = 0.$$
(1.3)

(ii) The Extrapolated Peak. When graphical methods are used, statistical fluctuations make it difficult to determine the exact maximum of a smooth curve. Hence spectroscopists developed the technique of drawing several horizontal chords across the upper portion of the profile, determining their midpoints, and drawing a smooth "bisector curve" (often simply a straight line) through these midpoints; the bisector was then extrapolated to intersect the line profile to obtain the peak [25]. This method is illustrated in figure 1. With the advent of computers various analytical modifications of this technique are now feasible; these are described more fully in section 6. We will denote the peak found by any of these methods as the *extrapolated peak*.



FIGURE 1. Extrapolation technique of locating peak by means of a smooth bisector curve through chord midpoints.

For symmetric lines it is also possible to use the average of the midpoints of several chords [26] or even the midpoint of a single chord [27] as a means of determining the peak. (Since the lines are assumed symmetric, this technique might equally well be said to determine the centroid or the median.) For reasons of mathematical similarity, this approach is considered along with the extrapolated peak.

2. Preliminary Considerations

2.1. Experimental Assumptions

Our present analysis is primarily from the viewpoint of the spectroscopist rather than the crystallographer. The spectroscopist is chiefly interested in a simple, accurate, reproducible criterion for measuring wavelengths; he normally employs a device with a relatively narrow instrumental window (e.g., a double-crystal spectrometer), which does not greatly distort the natural line profile. The crystallographer uses x rays as a tool to study crystal structure and frequently employs a powder diffractometer, which greatly broadens the natural line.

These differences may lead to the choice of different wavelength criteria. For example, the crystallographer may employ the centroid and the spectroscopist use the peak. No fundamental difficulty should result, provided that these two features can be related with high accuracy for the rather limited number of intense lines commonly used by crystallographers.

We will adopt the following assumptions as to experimental conditions:

(A) There is no drift in x-ray intensity incident on the spectrometer.

(B) Both counting time intervals and angular positions (and hence the corresponding wavelength or energy scales) on the spectrometer can be measured with negligible error.

(C) The instrumental window causes a negligible shift in the selected feature for the wavelength criterion, or the necessary correction may be made with negligible error.

(D) Measurements are recorded at a finite number of closely spaced points (usually at equal abscissa intervals). Consequently it will always be assumed possible to replace an integral by the corresponding sum, and vice versa, whenever convenient.

(E) Photon counts at the individual data points are statistically independent of one another and follow the Poisson distribution, and the number of counts recorded is always sufficiently large so that the latter may be approximated by a normal distribution. It follows that the variance (i.e., the square of the standard deviation) for a total count N at the *i*th point is given by

$$\sigma_N^2 = N. \tag{2.1}$$

Experimental tests [13] are in good accord with these assumptions.

(F) Background is relatively small compared to the peak intensity and is free from drift. In most of the analysis we will also assume that the background is independent of wavelength over the relevant portion of the profile; however, the effect of a linear variation will also be briefly discussed.

Background intensity B may be determined experimentally by preliminary measurements at points well removed from the peak on either side. This is then subtracted from the experimentally observed value, I_{obs} , for each point to give the computed intensity, i.e.,

$$I = I_{\rm obs} - B. \tag{2.2}$$

An error in the background *correction B* may produce a systematic effect throughout a given run, but will not affect the statistical error discussed under assumption (E) above. Hence the effective variance of I is

$$\sigma^2(I) = \sigma^2(I_{\text{obs}}). \tag{2.3}$$

Thus it is governed by the total intensity, both line and background.

2.2. Lorentzian Line Profile

There is both theoretical [28] and experimental [29] evidence to indicate that many x-ray emission line profiles are closely approximated by a Lorentzian curve (often referred to as a witch), which is given by

$$I(x) = I_p \left[1 + \frac{4(x - x_p)^2}{W^2} \right]^{-1}, \qquad (2.4)$$

where I and x represent intensity and wavelength respectively, I_p and x_p denote the respective coordinates of the peak, and W represents the *full width* of the curve at *half maximum intensity*.

Frequently the Lorentzian curve may be a fair approximation to the true line profile, but *not* sufficiently good to be assumed a priori. In such cases, after the standard deviation has been calculated in generalized form, we may then insert the Lorentzian expression, eq (2.4), only for the purpose of obtaining an error estimate. We will term such a line profile a quasi-Lorentzian.

It is convenient to normalize I and x in the above expression by defining

$$g = I/I_p, \tag{2.5}$$

$$v = 2(x - x_p)/W.$$
 (2.6)

Except where otherwise indicated, all equations will be expressed in terms of these normalized coordinates. The Lorentzian equation then becomes

$$g(v) = (1+v^2)^{-1}.$$
 (2.7)

2.3. Asymmetric Lines

Many prominent x-ray emission lines are asymmetric; this property has usually been described by an index of asymmetry given by $(v_+ - v_p)/(v_p - v_-)$, where v_p is the wavelength of the peak while v_+ and v_- represent the wavelengths of the half intensity points (*i.e.*, $g_{\pm} = g_p/2$) on the long and short wavelength sides respectively. Under this definition asymmetries ranged from zero to infinity with a symmetric line having a value of unity.

More recently Sauder [10] proposed the definition

$$s = \frac{(v_{+} - v_{p}) - (v_{p} - v_{-})}{(v_{+} - v_{p}) + (v_{p} - v_{-})} = \frac{v_{+} + v_{-} - 2v_{p}}{v_{+} - v_{-}}$$
(2.8)

With this convention we have $-1 \le s \le 1$, with s=0 corresponding to a symmetric line. We will employ this definition throughout the present paper.

Asymmetric line profiles may be represented by a simple modification of eq (2.7), viz,

$$g(v) = \begin{cases} \{1 + [v/(1-s)]^2\}^{-1} & v \le 0\\ \{1 + [v/(1+s)]^2\}^{-1} & v > 0. \end{cases}$$
(2.9)

Figure 2 shows typical examples of one symmetric and one asymmetric line fitted by eqs (2.7) and (2.9) respectively.

While eq (2.9) furnishes a reasonably good model function, it has at its peak a discontinuity in the second derivative, which seems physically unrealistic. Hence, in some calculations which are sensitive to behavior at this point, it is preferable to employ the alternative model function

$$g(v) = (1 + \zeta v) / (1 + v^2),$$
 (2.10)

which has a qualitatively similar behavior for $\zeta \ll 1$, provided we set $\zeta = 2s$ and translate the origin by $\zeta/2$.

2.4. Gaussian Profile

While a Gaussian profile is not representative of most lines encountered in x-ray spectroscopy, it does furnish another example which is straightforward to compute mathematically. Hence it is of some interest to consider this case in order to see how far the results for a quasi-Lorentzian can be qualitatively applied to other profiles. The Gaussian case is represented by

$$g(v) = \exp\left[-(\ln 2)v^2\right]$$
(2.11)

in place of eq (2.7). We may then define a quasi-Gaussian profile analogously to the quasi-Lorentzian one.

2.5. Variance of Data Points

To express the variances of the individual data points in terms of the new normalized variables, we note that the intensity I is defined as $I = N/\Delta t$, where Ncounts have been recorded in an interval Δt . The corresponding variance of the intensity thus becomes $\sigma_N^2/(\Delta t)^2$ or, by eq (2.1), simply $I/\Delta t$. Employing eq (2.5) to compute the variance of g, we find

$$\sigma_a^2 = \sigma^2(I)/I_p^2 = g/I_p \Delta t. \qquad (2.12)$$

In the case of background the calculation is similar except that, in accordance with eq (2.3), we must replace I by I_{obs} , which is given by eq (2.2). For constant background B, the result may be expressed as

$$\sigma_a^2 = (g + \eta)/I_p \Delta t, \qquad (2.13)$$

where

$$\eta = B/I_p. \tag{2.14}$$

3. Centroid

3.1. Truncation Procedure

To complete the definition of the centroid given by eq(1.1) we must specify the truncation limits. Taylor,

Mack, and Parrish [14] have discussed at length several alternative definitions from the viewpoint of crystallographers. They recommended using a specified



FIGURE 2. (a) Lorentzian curve fitted to experimental data for W K α_1 line obtained with a double-crystal spectrometer in (1, +3)position. (b) Model function of eq (2.9) compared with experimental curve for the highly asymmetric Fe K α_1 line.

interval symmetric about the centroid; this interval may be located by successive approximations. This definition permits a rather straightforward error analysis and will be employed here.

Even if we knew the correct truncation limits exactly, there would be an error in the centroid due to statistical fluctuations in intensities; we will define this as the *idealized statistical error*, ϵ_c , and denote the corresponding standard deviation by σ_c . Since the limits are in fact determined by successive approximations which are in turn influenced by these statistical errors, an additional uncertainty occurs. As demonstrated below, this introduces a multiplicative factor, which will be denoted as the *truncation mislocation factor*, f_c . The product of these two quantities then gives the *total statistical error*, (σ_{c})_{tot}.

3.2. Idealized Statistical Error

For N equally spaced abscissa intervals the centroid definition in eq (1.1) may be rewritten in terms of summations and normalized variables, given by eqs (2.5–6), as

$$v_c = \sum_i v_i g_i / \sum_i g_i. \tag{3.1}$$

 $(1 \le i \le N \text{ in all summations, unless otherwise specified.})$ It follows that

$$\frac{\partial v_c}{\partial g_j} = \frac{v_j}{\sum_i g_i} - \frac{\sum_i v_i g_i}{(\sum_i g_i)^2} = \frac{v_j - v_c}{\sum_i g_i}.$$
(3.2)

Since the g_j 's are statistically independent with variances given by eq (2.13), the variance of the centroid is now given by

$$\sigma_c^2 = \sum_j (\partial v_c / \partial g_j)^2 \sigma_j^2 = (\sum_i g_i)^{-2} \sum_j (v_j - v_c)^2 (g_j + \eta) / I_p \Delta t_j.$$
(3.3)

We may immediately write this in integral form for the case of equal time intervals, noting the $\Delta v = 2V/N$ for the normalized abscissa range $-V \le v \le V$ and that the total counting time $T = N\Delta t$. The result is

$$(\sigma_c)_{eq \Delta t} = (2V/I_pT)^{1/2} \left[\int_{-V}^{V} g(v) \, dv \right]^{-1} \\ \left\{ \int_{-V}^{V} (v - v_c)^2 [g(v) + \eta] dv \right\}^{1/2}$$
(3.4)

In general, it may be necessary to employ fractional intervals for Δv at the end points in order to obtain a range symmetric about v_c . However, this refinement should not affect the error estimate appreciably, provided N is reasonably large. Furthermore we may frequently bypass the use of fractional intervals by the method given below in section 3.4.

3.3. Optimization of Statistical Error

The idealized statistical error may be reduced by proper choice of the time intervals Δt_i . Let us fix the

total time T, which is given by

$$\Sigma_j \Delta t_j = T. \tag{3.5}$$

We may then use the method of Lagrangian multipliers to minimize the j summation in eq (3.3) subject to the constraint of eq (3.5) with the result

$$-[(v_j - v_c)^2(g_j + \eta)/(\Delta t_j)^2] + \lambda^2 = 0. \quad (3.6)$$

Solving for Δt_j and employing eq (3.5) to evaluate λ yields

$$\Delta t_j = T |v_j - v_c| (g_j + \eta)^{1/2} / \Sigma_i |v_i - v_c| (g_i + \eta)^{1/2}, \quad (3.7)$$

where the absolute value sign is used to assure that all time intervals are positive. This equation indicates that, for optimum error, more time should be spent at points on the sides than those at the center; a large background tends to equalize the optimized intervals, as might be expected.

Inserting these values in eq (3.3) and expressing the result in integral form, as done with eq (3.4), we find for the optimized error

$$(\sigma_c)_{\text{opt}} = \int_{-V}^{V} |v - v_c| [g(v) + \eta]^{1/2} dv / (I_p T)^{1/2} \int_{-V}^{V} g(v) dv.$$
(3.8)

This result is a special case of that given by Wilson, Thomsen and Yap [12]. From eqs (3.4) and (3.8) we may form the optimization ratio

$$\frac{(\sigma_c)_{\text{opt}}}{(\sigma_c)_{\text{eq }\Delta t}} = \frac{\int_{-V}^{V} |v - v_c| [g(v) + \eta]^{1/2} dv}{\left\{ 2V \int_{-V}^{V} (v - v_c)^2 [g(v) + \eta] dv \right\}^{1/2}}.$$
 (3.9)

The above expression is simply the ratio of the mean value of the function $|v - v_c|[g(v) + \eta]^{1/2}$ to its root-mean-square value. Hence its qualitative behavior can readily be visualized by plotting this function for any specific case.

3.4. Truncation Mislocation Factor

Let us define our coordinate system with origin at the true centroid. If the desired truncation limits were known exactly, there would be only the idealized statistical error ϵ_c as discussed in section 3.1. Actually the limits are never exactly known; we may begin with a trial value of $v_c^{(0)}$ for the centroid and use this to compute a first approximation $v_c^{(1)}$. Similarly successive approximations may be computed, the *k*th approximation being denoted by $v_c^{(k)}$.

In eq (3.1), the denominator is proportional to the area under the profile in the range $-V \le v \le V$; this is insensitive to small location errors for a curve of moderate asymmetry. The numerator represents a first moment and is sensitive to such errors. For the (k+1)th approximation the range is

$$-V + v_c^{(k)} \leq v \leq V + v_c^{(k)};$$

if $v_c^{(k)}$ should vanish, we would obtain the idealized statistical error, ϵ_c , for the particular curve. Hence eq (3.1) may be rewritten as

$$v_{c}^{(k+1)} \approx \int_{-V+v_{c}^{(k)}}^{V+v_{c}^{(k)}} vg(v)dv \Big/ \int_{-V}^{V} g(v)dv \approx \epsilon_{c} + r_{c}v_{c}^{(k)}, \quad (3.10)$$

where

$$r_c \equiv V[g(V) + g(-V)] / \int_{-V}^{V} g(v) dv.$$
 (3.11)

Now r_c is simply the ratio of the average height of of the profile at the end points to the average height over the entire range; hence $r_c < 1$. The recursion relation, eq (3.10), and the initial condition are satisfied by

$$v_c^{(k)} = \epsilon_c \sum_{m=0}^{k-1} r_c^m + r_c^k v_c^{(0)}, \qquad (3.12)$$

which converges to the value v_c given by

$$v_c = \epsilon_c / (1 - r_c). \tag{3.13}$$

The denominator on the right is independent of the particular curve. Hence the standard deviations given by eqs (3.4) and (3.8) (which represent averages over several curves) must be multiplied by a *truncation* mislocation factor f_c , i.e.,

$$f_c \equiv (\sigma_c)_{\text{tot}} / \sigma_c = 1 / (1 - r_c). \tag{3.14}$$

The above results also suggest a means of bypassing the successive iterations. For k=1, eq (3.12) becomes simply $v_c^{(1)} = \epsilon_c + r_c v_c^{(0)}$. Solving for ϵ_c and substituting in eq (3.13) yields

$$v_c - v_c^{(0)} = \left(\frac{v_c^{(1)} - v_c^{(0)}}{1 - r_c} \right).$$
(3.15)

Thus, if the trial value $v_c^{(0)}$ is a reasonably good guess, the value of r_c may be approximated and v_c then computed from the above expression without further iterations.

3.5. Application to Quasi-Lorentzian Profile

If the line profile is quasi-Lorentzian (see sec. 2.2), we may substitute eq (2.7) in the various expressions for the centroid to obtain more explicit results. Since $v_c = 0$ for this model, eq (3.4), for equal time intervals, yields

$$(\sigma_c)_{eq \Delta t} = (V/I_pT)^{1/2} (\tan^{-1} V)^{-1} [V - \tan^{-1} V + (\eta V^3/3)]^{1/2}.$$
 (3.16)

This result is essentially the same as that obtained by Pike and Wilson [16]. In figure 3 it has been transformed to the wavelength variable x by means of eq (2.6) and is plotted for various values of range and background.



FIGURE 3. Idealized statistical error of centroid of a quasi-Lorentzian profile as function of truncation range for various values of background parameter η .

Similarly we may integrate eq (3.9) explicitly for the quasi-Lorentzian case; however, the resulting expression is rather complicated and not particularly informative. For the special case of zero background, the result in simply

$$(\sigma_c)_{\rm opt}/(\sigma_c)_{\rm eq} \Delta t$$

$$= [(1+V^2)^{1/2} - 1][V(V - \tan^{-1} V)]^{-1/2}.$$
(3.17)

This ratio varies from 0.86 at V=0 to 1.00 as $V \rightarrow \infty$. (Detailed calculations indicate that it is insensitive to background.) Hence only a limited improvement can be achieved by optimizing the data-taking procedure.

The truncation mislocation factor is found by combining eqs (2.7), (3.11), and (3.14), with the result

$$f_c = \frac{(1+V^2) \tan^{-1} V}{(1+V^2) \tan^{-1} V - V}.$$
 (3.18)

This factor is unity for infinite V, attains a value of 2.75 for V=1.0, and approaches infinity as $V \rightarrow 0$.

Idealized statistical errors for the case of zero background and equal time intervals have been calculated from eq (3.16), multiplied by the above factor to obtain the total error, and plotted in figure 4 (after conversion to the wavelength variable x). This curve reaches a minimum for $V \approx 1$, in which case the *total statistical error* is given by

$$(\sigma_{xc}/W)_{tot} = \sigma_c/2 = 0.81/(I_pT)^{1/2}, \quad (V=1). \quad (3.19)$$

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(Note that V=1 implies the centroid of a relatively narrow truncated portion of the profile, rather than the centroid definition as used by some crystallographers.) Optimization can reduce this error by only 11 percent, as shown by eq (3.17) and by figure 4.



FIGURE 4. Total statistical error of centroid of a quasi-Lorentzian profile as a function of truncation range for equal and for optimized counting time intervals (zero background).

3.6. Application to Quasi-Gaussian Profile

We may carry out similar calculations for the quasi-Gaussian profile defined by eq (2.11). The minimum error occurs at $V \approx 1.8$, for which the numerical factor in eq (3.19) is reduced to 0.62. In contrast to the Lorentzian case, this range includes over 90 percent of the area under the profile; this is due to the rapid decay of the tails of a Gaussian.

Optimization of time intervals can reduce the above figure by about 8 percent. For large truncation ranges and zero background, optimization could be of crucial importance; the numerical factor would then asymptotically approach 0.68 in sharp contrast with the case of equal intervals, where the error approaches infinity. However, any appreciable background will cause an increase in the error at large ranges and greatly reduce the advantage of optimization.

3.7. Systematic Errors

There are at least two sources of systematic error whose effects may depend upon the choice of wavelength criterion adopted; these are *undetected* background and the presence of unresolved satellites. Since we consider only the case where truncation limits are taken symmetrically about the centroid, the resulting centroid position must be unaffected by a *constant* background, even if no correction is made for it. However, if there is an undetected linearly varying background, i.e., if the observed intensity (after the experimental background correction) is given by

$$g_{\text{obs}}(v) = g(v) + \eta + \mu v, \qquad (3.20)$$

the linear term will cause a systematic error. Assuming that the curve is almost symmetrical, we may as a first approximation calculate the centroid for a symmetric range about the origin and then apply eq (3.15)to find the centroid of the observed curve. The result may be expressed as

$$v_c + \delta v_c = \frac{v_c^{(1)} + \delta v_c^{(1)}}{1 - r_c} = \frac{\int_{-V}^{V} vg(v)dv + (2\mu V^3/3)}{\int_{-V}^{V} g(v)dv - V[g(V) + g(-V)]},$$
(3.21)

where δv_c represents the systematic error due to the background term in μ . For a quasi-Lorentzian profile this term becomes

$$\delta v_c = \frac{\mu V^3 (1+V^2)}{3[(1+V^2) \tan^{-1} V - V]}$$
(3.22)

This error is roughly equal to μ for V=1 and to $0.2\mu V^3$ for $V \ge 1$. Thus for V=1 and $I_pT \sim 10^6$, we must have $\mu \sim 10^{-3}$ to keep this systematic error of the same order as the statistical one; for $V \ge 1$, the requirement is clearly far more stringent. It should be reemphasized that μ refers only to the undetected portion of the background, i.e., it is an error term in the background correction.

A satellite, whose amplitude is likely to be voltage dependent, may be strong enough to cause an appreciable systematic error in the centroid and yet not be resolved. For large truncation ranges, the worst situation occurs with the satellite just short of the truncation limit; its moment arm is then almost equal to V. If W_s denotes the satellite width and α_s the ratio of its amplitude to that of the main peak, the systematic error is roughly $V\alpha_s W_s | W$. For $V \sim 1$, the worst situation occurs when the satellite peak is appreciably inside the truncation limit; the error is then of the order of 0.5 α_s and is less sensitive to W_s .

3.8. Effect of Asymmetry

The form of eqs (3.4) and (3.9) indicates that the centroid statistical errors should be insensitive to moderate asymmetries since they depend on the shape only through integral expressions involving the normalized profile. Furthermore it seems clear that the error should not depend on the sign of s (the index of asymmetry defined by eq (2.8)); hence we might expect that the relative change in the standard deviation is of the order of s^2 . This expectation was verified [13] by taking the model function of eq (2.9) with asymmetry s=0.24 (corresponding to the Fe K α_1 line) and inserting it in eq (3.4). The resulting error was about 1 percent greater than that for the symmetric quasi-Lorentzian.

The actual displacement of the centroid from the peak will depend both on the range and on the model function employed. For V=1 the displacement $v_c - v_p$ is approximately 0.67 s with eq (2.9) and 0.50 s with eq (2.10). In terms of wavelength these expressions become 0.34 sW and 0.25 sW, respectively.

4. Median

4.1. Computation and Truncation Procedure

As in the case of the centroid, we must employ a truncated portion of the line profile for a practical determination of the median. For simplicity, we will adopt the same convention, viz, a specified range which is symmetric about the median and which may be determined by successive approximations. The *total statistical error* will again be given by an *idealized statistical error*, ϵ_m , with corresponding standard deviation σ_m , multiplied by a *truncation mislocation factor*, f_m .



FIGURE 5. Illustration of median located in the (M+1)th interval, as used in derivation of eq (4.3).

In order to calculate the median error it is helpful to derive a more explicit expression for the median than that given by eq (1.2). Let us pass from the continuous to the discrete case and represent the data by the histogram of figure 5, where each abscissa value corresponds to the *midpoint* of the base of the corresponding rectangle. If the median is located in the (M+1)th interval, its position x_m is defined by

$$_{m} = x_{M} + (\Delta x/2) + \Delta x_{m}. \tag{4.1}$$

Equation (1.2) now becomes

$$\sum_{i=1}^{M} I_i \Delta x + I_{M+1} \Delta x_m = \sum_{i=M+1}^{N} I_i \Delta x - I_{M+1} \Delta x_m. \quad (4.2)$$

Rearranging and inserting the normalized variables defined by eqs (2.5-6) yields

$$\Delta v_m = (\Delta v/2g_{M+1}) \left[\sum_{i=M+1}^N g_i - \sum_{i=1}^M g_i \right].$$
(4.3)

4.2. Idealized Statistical Error

The statistical error in v_m is just that in Δv_m . The calculation is similar to that for the centroid in section 3.2, except that two cases must be considered for the required partial derivatives. For $i \neq M+1$, eq (4.3) yields

$$[\partial (\Delta v_m) / \partial g_i]^2 = (\Delta v / 2g_{M+1})^2. \tag{4.4}$$

For the special case in which i = M + 1, we obtain

$$\left[\partial \left(\Delta v_{m}\right)/\partial g_{M+1}\right] = -\left(\Delta v/2g_{M+1}^{2}\right)\left[\sum_{i=M+2}^{N}g_{i}-\sum_{i=1}^{M}g_{i}\right]. (4.5)$$

The summations may now be eliminated through the help of eq (4.3); it follows that

$$\left[\partial \left(\Delta v_m\right)/\partial g_{M+1}\right] = \left(\Delta v - 2\Delta v_m\right)/2g_{M+1}.$$
 (4.6)

By figure 5, $0 \le \Delta v_m \le \Delta v$. Hence it is clear that the right side of eq (4.4) represents an upper limit for i=M+1; if $N \ge 1$ we may employ this equation for all *i* without serious error.

The calculation then proceeds as for the centroid, with the result

$$(\sigma_m)_{\mathrm{eq}\ \Delta t} = (V/2g_m^2 I_p T)^{1/2} \left\{ \int_{-V}^{V} [g(v) + \eta] dv \right\}^{1/2}, \quad (4.7)$$

where we have set $g_{M+1} \approx g_m$, the ordinate at the median.

4.3. Optimization of Statistical Error

The optimization procedure may again be carried out by the method of Lagrangian multipliers. The optimum time intervals are

$$\Delta t_j = T(g_j + \eta)^{1/2} / \sum_i (g_j + \eta)^{1/2}, \qquad (4.8)$$

which yield for the optimization ratio

$$\frac{(\sigma_m)_{\text{opt}}}{(\sigma_m)_{\text{eq }\Delta t}} = \frac{\int_{-V}^{V} [g(v) + \eta]^{1/2} dv}{\left\{ 2V \int_{-V}^{V} [g(v) + \eta] dv \right\}^{1/2}}.$$
 (4.9)

4.4. Truncation Mislocation Factor

Calculation of the truncation mislocation factor is also similar to that for the centroid case. Let the origin be located at the true median position and the idealized statistical error be ϵ_m . Then, if the range for the (k+1)th approximation is $-V + v_m^{(k)} \leq v$ $\leq V + v_m^{(k)}$, eq (1.2) is approximated by

$$v_m^{(k+1)} \approx (1/2g_m) \left[\int_0^{V+v_m^{(k)}} g(v) \, dv - \int_{-V+v_m^{(k)}}^0 g(v) \, dv \right]$$
$$\approx \epsilon_m + r_m v_m^{(k)}, \quad (4.10)$$

where

$$r_m \equiv (1/2g_m) \left[g(V) + g(-V) \right]. \tag{4.11}$$

The factor r_m represents the ratio between the average ordinate at the end points and the ordinate at the median position; it will normally be substantially less than unity. Hence the same analysis as for the centroid follows and the truncation mislocation factor has the same form as eq (3.14), i.e., $f_m = 1/(1-r_m)$. Equation (3.15) is also applicable to bypass the need for successive approximations, with v_m and r_m replacing v_c and r_c .

4.5. Application to Quasi-Lorentzian Profile

For the case of a quasi-Lorentzian line (which implies that $g_m \approx 1$), eqs (2.7) and (4.7) give

$$(\sigma_m)_{\rm eq} \Delta t = \{ V(\tan^{-1} V + \eta V) / I_p T \}^{1/2}.$$
(4.12)

This equation is illustrated in figure 6. If this result is reexpressed in terms of the total number of counts for the case of zero background, it agrees with the calculation of Knowles [19] within the approximation of the latter.



FIGURE 6. Idealized statistical error of median of a quasi-Lorentzian profile as function of truncation range for various values of background parameter η .

Equation (4.9) may easily be integrated for the case of zero background to yield

$$\frac{(\sigma_m)_{\text{opt}}}{(\sigma_m)_{\text{eq}}\,\Delta t} = \frac{\ln \left[V + (1+V^2)^{1/2}\right]}{\left[V\,\tan^{-1}\,V\right]^{1/2}}.$$
(4.13)

The factor r_m defined by eq (4.11) is simply $(1+V^2)^{-1}$; the truncation mislocation factor then becomes

$$f_m = 1/(1 - r_m) = (1 + V^2)/V^2.$$
 (4.14)

Assuming zero background, we may calculate the total statistical error for the case of equal time intervals by combining eqs (4.12) and (4.14); the optimized case is obtained through multiplication by the ratio given in eq (4.13). The results are plotted in figure 7. For equal time intervals we find that the minimum error occurs for $V \approx 1.2$ and is

$$(\sigma_{xm}/W)_{\text{tot}} = \sigma_m/2 = 0.88/(I_pT)^{1/2}, \quad (V=1.2).$$

(A.15)

Optimized time intervals reduce this figure by only about 1 percent.



FIGURE 7. Total statistical error of median of a quasi-Lorentzian profile as a function of truncation range for equal and for optimized counting time intervals (zero background).

4.6. Application to Quasi-Gaussian Profile

When the results for the median are applied to a quasi-Gaussian profile, the minimum error occurs for $V \approx 1.7$, with the numerical factor in eq (4.15) becoming 0.76. Optimized time intervals can reduce this figure by about 5 percent. As in the case of the centroid, optimization appears to be of great significance for large truncation ranges and zero background; the numerical factor then approaches asymptotically a value of 0.75. However, this advantage would be greatly reduced by the presence of any appreciable background.

4.7. Systematic Errors

Like the centroid, the median is immune to any systematic error from a constant background, provided that the truncation limits are defined as in sec. 4.1. A linearly varying background $\eta + \mu v$ may be shown to produce a systematic error δv_m equal to μ for V = 1 and approaching $\mu V^2/2$ for $V \ge 1$.

For a large truncation range and a satellite with a width comparable to that of the main line the worst systematic error occurs when the satellite is centered at $\pm V/2$. In this case substantially all its area lies to one side of the true median and is included in the integration. This area is $\pi \alpha_s W_s/W$; inspection of eq (4.3) shows that this will cause a systematic error, δv_m , equal to $\pi \alpha_s W_s/2W$. For smaller ranges the error will be magnified by the truncation mislocation factor; on the other hand it will be reduced by the fact that not all of the satellite area is included within the limits of integration and the included part has significant portions on both sides of the true median. The net result will usually be to reduce the above estimate quite substantially.

4.8. Effect of Asymmetry

As in the case of the centroid, we might expect that the statistical error is insensitive to asymmetry and that the relative change in the standard deviation is of the order of s^2 . This prediction has been tested [13] by a calculation with the Fe K α_1 line, for which s=0.24. The standard deviation is within roughly 1 percent of the value for a symmetric line.

For the truncation range V=1, the displacement of the median from the peak, i.e., $v_m - v_p$, is 0.57 s for eq (2.9) and 0.39 s for eq (2.10). For infinite range, the former gives a well-defined median with a displacement of 1.57 s; the latter model then becomes physically absurd, since it implies negative values of g(v).

5. Geometrical Peak

5.1. Orthogonal Polynomial Technique

In order to determine the geometrical peak of a line profile we must adopt some method of drawing a smooth curve through the data points. When the form of the profile is not known a priori, it seems reasonable to fit the data with an empirical polynomial by the method of least squares, preferably through the use of a computer.

Forsythe [30] has discussed the difficulties which arise with higher degree polynomials, due primarily to roundoff errors, when this method is applied directly. Hence in such cases he has recommended least squares adjustments by means of the orthogonal polynomial technique, which alleviates the roundoff problem. We will adopt this approach and employ a weighting function for the *j*th point which is inversely proportional to its variance, i.e.,

$$w_j = K/\sigma_j^2. \tag{5.1}$$

With a slight modification of Forsythe's presentation,

a series of orthogonal polynomials may then be defined by

$$\sum_{j} w_{j} \varphi_{m}(z_{j}) \varphi_{n}(z_{j}) \Delta z = \delta_{mn}, \qquad (5.2)$$

where *m* and *n* denote the degrees of the respective polynomials and *z* represents a new abscissa variable normalized such that $-1 \le z \le 1$ for the desired range. If the points are closely spaced and of equal weight, then under this definition the φ_n 's reduce to the Legendre polynomials. These polynomials may be generated by a variety of techniques, e.g., the Schmidt orthogonalization process or a set of recursion relations given by Forsythe [30].

Let us assume that the *true profile* $\tilde{g}(z)$ is an *M*th degree polynomial, which may be expressed in the form

$$\tilde{g}(z) = \sum_{n=0}^{M} a_n \varphi_n(z).$$
(5.3)

The true values of the coefficients (the a_n 's) are, of course, unknown. However, if we denote the (normalized) observed intensity at the *j*th point by g_j and compute the coefficients by the relation

$$a_n = \sum_j w_j \varphi_n(z_j) g_j \Delta z, \qquad (5.4)$$

we can show [13] that the resulting polynomial is a least squares fit to the data.

We may now show that the coefficients are statistically independent quantities with equal variances. Since the δg_j 's, i.e., the errors in g at the various points, are statistically independent, it follows immediately that the average $\langle \delta g_i \delta g_j \rangle = \delta_{ij} \sigma_j^2$. Combining this with eq (5.4) yields

$$\langle \delta a_m \delta a_n \rangle = (\Delta z)^2 \sum_i \sum_j w_i w_j \phi_m(z_i) \phi_n(z_j) \langle \delta g_i \delta g_j \rangle$$
$$= (\Delta z)^2 \sum_j w_j^2 \phi_m(z_j) \phi_n(z_j) \sigma_j^2. \tag{5.5}$$

Eliminating σ_j^2 by eq (5.1) and applying eq (5.2) then shows

$$\langle \delta a_m \delta a_n \rangle = K \Delta z \delta_{mn}, \tag{5.6}$$

which proves the above statement and gives explicitly the variance of a_m .

5.2. Statistical Error

Let us now express the physical problem in terms of the normalized variable z, which was defined such that $-1 \le z \le 1$, i.e.,

$$z = v/V, \tag{5.7}$$

and set $g(v) = \tilde{g}(z)$. If we assume equal counting times Δt and put $K = 1/I_p \Delta t$ in eq (5.1), it follows with the help of eq (2.13) that

$$w_j = 1/(g_j + \eta).$$
 (5.8)

By this choice the orthogonal polynomials defined by eq (5.2) depend only on the *shape* of the observed profile and are independent of I_p and Δt . (Note that, in principle, the g_j 's in the above expression should be the true values rather than the experimentally observed ones. However, it may be shown [13] that the experimental ones may be used with negligible error under normal conditions.) When the above value of Kis substituted in eq (5.6), the result is

$$\langle \delta a_m \delta a_n \rangle = (\Delta z / I_p \Delta t) \,\delta_{mn} = (2 / I_p T) \,\delta_{mn} \qquad (5.9)$$

since $\Delta z = 2/N = 2\Delta t/T$.

To calculate the peak shift due to statistical error we first denote the fitted polynomial by $\hat{g}(z)$. This may be expressed as the sum of the true profile $\tilde{g}(z)$ and an error term $\delta \tilde{g}(z)$, caused by the δa_n 's, i.e.,

$$\hat{g}(z) \equiv \tilde{g}(z) + \delta \tilde{g}(z) = \tilde{g}(z) + \sum_{n=0}^{M} \delta a_n \varphi_n(z). \quad (5.10)$$

If the true peak is at z_p , for which $\tilde{g}'(z_p)$ vanishes, the observed peak will be at a point $z_p + \delta z_p$ such that

$$\tilde{g}'(z_p + \delta z_p) + \delta \tilde{g}'(z_p + \delta z_p) \approx \tilde{g}''(z_p) \delta z_p + \sum_{n=0}^{M} \delta a_n \phi_n'(z_p) \approx 0$$
(5.11)

with the neglect of second-order terms. By eqs (5.7) and (5.11) it follows that

$$\frac{\partial v_p}{\partial a_n} = V\left(\frac{\partial z_p}{\partial a_n}\right) \approx -\frac{V\phi'_n(z_p)}{\tilde{g}''(z_p)} = -\frac{\phi'_n(z_p)}{Vg''(v_p)} \cdot (5.12)$$

With the help of eqs (5.12) and (5.9) the standard deviation of the peak becomes

$$(\sigma_p)_{eq \Delta t} = \left\{ \sum_{n=0}^{M} \left(\frac{\partial v_p}{\partial a_n} \right)^2 \langle (\delta a_n)^2 \rangle \right\}^{1/2}$$
$$\approx \frac{1}{V} \left\{ \frac{2 \sum_{n=0}^{M} \left[\phi'_n(z_p) \right]^2}{I_p T \left[g''(v_p) \right]^2} \right\}^{1/2} \cdot (5.13)$$

(In this expression the quantity $g''(v_p)$ in the denominator may be adequately approximated by using the second derivative of the fitted curve, rather than that of the true one.) The φ_n 's have a rather insensitive dependence on range through the weighting function w_j in eq (5.2). Hence the error depends on range chiefly through the explicit factor V in the denominator and through the indirect effect on M; the larger the range, the higher will in general be the degree of the polynomial necessary to fit the data.

5.3. Goodness of Fit

Since in practice the proper value of M is not known a priori, we must determine this by some empirical test on the fitted curve. One such criterion is the χ^2 (see, for example, Bearden and Thomsen [32]). The residuals for the individual points are $g_j - \hat{g}(z_j)$, where g_j is the experimental value and $\hat{g}(z_j)$ the value of the smoothed fitted curve at the *j*th point; the variances are given by eq (2.13).

Thus the expression for χ^2 becomes

$$\chi^{2} = I_{p} \Delta t \sum_{j} [g_{j} - \hat{g}(z_{j})]^{2} / (g_{j} + \eta). \qquad (5.14)$$

When averaged over several runs, the average value $\langle \chi^2 \rangle$ should approximate the number of degrees of freedom, which is simply N - (M+1), where N is the number of data points and (M+1) the number of coefficients required for an Mth degree polynomial.

While the χ^2 test is an excellent criterion for a generally reasonable fit, we may often obtain a more sensitive indication of the best value for M by examining values of the $\langle a_n \rangle$'s, i.e., the polynomial coefficients in eq (5.3) averaged over several curves, say N_0 runs. The variance of $\langle a_n \rangle$ is found immediately by dividing eq (5.9) by N_0 . When the magnitude of the average value of a particular coefficient is less than its standard deviation, i.e.,

$$|\langle a_m \rangle| < (2/N_0 I_p T)^{1/2},$$
 (5.15)

it evidently contributes more error than useful information. If this inequality holds for all m > M, it will confirm the choice of an *M*th degree polynomial.

For lines of high symmetry it is usually best to use an even degree polynomial, since the last term improves the fit without appreciably contributing to the error given by eq (5.13). It has been found empirically [13] that for a range $V \approx 1$ and $I_pT \sim 10^6$ a 6th degree polynomial is usually adequate to represent the data. This holds for most of the strong K and L lines of medium and short wavelength. The highly asymmetric Fe K α_1 line is somewhat of a borderline case between a 6th and 8th degree fit, with the 8th apparently preferable.

5.4. Application to Quasi-Lorentzian Profile

If the line profile is quasi-Lorentzian with a range V=1 and $I_pT \sim 10^6$, theoretical calculations show that a 6th degree polynomial will satisfy the condition given by eq (5.15). The orthogonal polynomials have been evaluated for this case, with zero background, and substituted in eq (5.13) with the result [13]

$$\sigma_{xp}/W = \sigma_p/2 = 1.67/(I_pT)^{1/2}, \qquad (V=1, M=6).$$

(5.16a)

for the standard deviation in terms of x. It may be shown that the numerical factor is roughly proportional to $M^{3/2}$.

We have checked this equation experimentally with six sets of data on the W K α_1 line, comprising a total of 35 curves. The results, as shown in table 1, indicate rather good agreement.

TABLE 1. Comparison of theoretical (eq (5.16a)) and experimental standard deviations of the geometrical peak of the W K α_1 line for a 6th degree polynomial fit with range V=1.

Crystal settings	No. of curves	$\langle \chi^2/{ m D.F.} angle$	$\sigma_{ m exp}$	$\sigma_{ m theor}$
(2, -3)	7	1.1	0.0046W	0.0033W
(2, -3)	5	1.3	.0035W	.0036W
(2, -3)	6	0.9	.0042W	.0037W
(2, 3)	7	1.1	.0038W	.0030W
(2, 3)	4	1.0	.0032W	.0033W
(2, 3)	6	1.0	.0032W	.0033W

Since the geometrical peak is usually determined with a range $V \sim 1$, background will normally be a rather minor factor. We may obtain an estimate of the background effect as follows: The average value of g(v) over the range V=1 is easily computed from eq (2.7) and found to be $\pi/4$. If we assume equal weights and employ this average value of g in eq (5.8), it follows that for zero background $\varphi_n(v) = (\pi/4)^{1/2} \pi_n(v)$, where the π_n 's are the orthonormal forms of the Legendre polynomials. If these are used in eq (5.13), the numerical factor in the above expression becomes ▶ 1.68, a change of less than 1 percent. Hence it seems reasonable to adopt this same approximation for a nonzero background. Thus for a range V=1, the average value of the observed profile is $(\pi/4) + \eta$ and eq (5.16a) becomes

$$\sigma_{xp}/W \approx [1 + (4\eta/\pi)]^{1/2} [1.67/(I_pT)^{1/2}], \quad (V=1).$$
(5.16b)

5.5. Optimization of Statistical Error

The time intervals, i.e., the Δt 's, enter eq (5.13) only implicitly through the definition of the orthogonal polynomials in eq (5.2). Because of this indirect relationship it does not seem feasible to optimize the time intervals for minimum statistical error by the same straightforward method used for the centroid and median. Hence a somewhat less satisfactory alternative approach has been adopted for the peak.

After passing from the sum to the integral in eq (5.2), we may arbitrarily assign a weighting function w(z) to obtain one of the standard sets of orthogonal polynomials. (For a concise summary of several well known examples, see Abramowitz and Stegun [31].) Thus, for example, assigning w(z) = 1 generates the Legendre polynomials.

Equations (5.1) and (2.13) then fix the relative values of the time intervals required to produce the desired weight. Summing these and equating to the total time T gives the constant K in eq (5.1), which may next be substituted in eq (5.6). It is then straightforward to obtain an error expression analogous to eq (5.13). We have applied this procedure to a quasi-Lorentzian profile with zero background for three cases, viz, Legendre polynomials and Chebyshev polynomials of the first and second kind. Table 2 shows the results for a 6th degree polynomial fitted over a range V=1, with the previously treated case of equal time intervals listed for comparison. In this instance the latter turns out to give the lowest error.

TABLE 2. Comparison of standard deviations obtained for the geometrical peak with a 6th degree polynomial fit and a range V = 1.

z represents the absciss	a variable normalized	such that the range	becomes $-1 \le z \le 1$.
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Weighting function	Polynomials	$(\sigma_{xp}/W)(I_pT)^{1/2}$
$\begin{array}{c} 1+z^2 \\ 1 \\ (1-z^2)^{1/2} \\ (1-z^2)^{-1/2} \end{array}$	(Equal times – see sec. 5.4) Legendre Chebyshev (first kind) Chebyshev (second kind)	1.67 1.68 1.76 1.70

Various other ranges and degrees of polynomials were analyzed. In most cases varying the weighting function did not affect the error by more than a few percent. Hence it seems that no significant improvement in the peak error can be obtained by optimizing time intervals.

The calculations described above show that, for the case of Legendre polynomials, we may replace eq (5.16a) by the approximate expression

$$\sigma_{xp}/W \approx 0.13 (M/V)^{3/2} (\tan^{-1} V)^{1/2} (I_p T)^{1/2}, \qquad (\eta = 0),$$
(5.16c)

where M is the degree of the polynomial. For the range $0.5 \le V \le 1$ and M = 4, 6, 8, this approximation is good to within 5 percent; it may also be used for other weighting functions, but will be a somewhat cruder estimate. It is important to note that M itself is implicitly a function of V, as discussed in section 5.2.

5.6. Application to Quasi-Gaussian Profile

The peak error was also computed for the quasi-Gaussian profile as given by eq (2.11). For simplicity, we employed Legendre polynomials according to the procedure outlined in the previous section. With $I_pT \sim 10^6$ a 4th degree polynomial gave an adequate fit, as judged by the criterion of eq (5.15). For the range V=1 the numerical factor in eq (5.16a) was then reduced to 1.40.

5.7. Systematic Errors

Systematic errors in the geometrical peak due to background and unresolved satellites are easily treated. A linear background, as given by eq (3.20), will have a slope μ ; the resulting slope of the observed profile near the origin is approximately $g''(v_p)\delta v + \mu$, which vanishes when $\delta v_p = -\mu/g''(v_p)$ or, in the case of a quasi-Lorentzian, $\delta v_p = \mu/2$.

The maximum slope of a quasi-Lorentzian satellite with amplitude α_s and width W_s is $3\sqrt{3} \alpha_s W/8W_s$. This plays the same role as μ in the above expression, giving a systematic error $\delta v_p = 3\sqrt{3} \alpha_s W/16W_s$ for the worst case of an unresolved satellite.

There is an additional systematic error in the geometrical peak due to the degree of the polynomial used to approximate the profile. If the test of eq (5.15)controls the fit, there might conceivably be any number of omitted orthogonal polynomials whose coefficients (i.e., the a_n 's) are just under $(2/N_0I_pT)^{1/2}$. It seems reasonable to estimate the error on the basis of the first neglected orthogonal polynomial with an appreciable derivative at the origin; for the quasi-Lorentzian case, this means the first neglected odd coefficient. Comparing the systematic error caused by a neglected coefficient $a_7 = (2/N_0 I_p T)^{1/2}$ with the statistical error of the mean of N_0 runs in which a 6th degree polynomial was used, we find that they are roughly equal. For a 2d or 4th degree fit, the systematic error can be still more serious.

However, if both the profile and the range of observation are nearly symmetric, the odd coefficients tend to be much smaller than the preceding even ones. Thus, if a_6 is barely significant statistically, it is likely that a_7 is substantially smaller. Hence the above estimate of systematic error is probably overly pessimistic, except perhaps in cases of high asymmetry, e.g., Fe K α_1 .

5.8. Effect of Asymmetry

The error quoted in sec. 5.4 is not particularly sensitive to moderate values of asymmetry. To check this point the Cu K α_1 line ($s \approx 0.06$) and the Fe K α_1 line ($s \approx 0.24$) were chosen as typical examples of low and high asymmetries. The required orthogonal polynomials were then generated by computer from the original experimental data of Bearden and Shaw [1] and substituted in eq (5.13). As a result, the factor of 1.67 in eq (5.16) was changed to 1.52 and 1.93 in the two respective cases.

5.9. Parabolic Fit

If the profile is fitted only in a relatively small region near the peak, a parabolic fit may be sufficient. In this case the weighting factor in eq (5.8) is substantially constant with the value $(1 + \eta)^{-1}$. Thus, in analogy to sec. 5.4, it follows from the integral form of eq (5.2) that the orthogonal polynomials are simply $(1+\eta)^{1/2}\pi_n(z)$, where the π_n 's are the normalized Legendre polynomials. The only one presently required is $\pi_1(z) = (3/2)^{1/2}z$. If we assume the line is quasi-Lorentzian and compute g''(0) = -2 from eq (2.7), eq (5.13) then yields

$$\sigma_{xp}/W = \sigma_p/2 = 0.433 (1+\eta)^{1/2}/V(I_pT)^{1/2}$$
. (5.17)

The calculation suggests the possibility of a significant reduction in error. Hence a rather detailed study [13] has been made on the range of validity of a parabolic fit. This showed that, on the assumption of a quasi-Lorentzian line with $I_p T \approx 10^6$, a parabolic fit will be satisfactory up to V=0.32; the right-hand side of eq (5.17) then becomes $1.35/(I_p T)^{1/2}$, an appreciable improvement over the 6th degree polynomial for V=1.

Furthermore, if the true curve is symmetric and if the range of observation is almost symmetric about the true peak, a parabola will locate the peak quite accurately even though it fails to satisfy the χ^2 test for goodness of fit. In this case the resulting systematic error is found to be proportional to ϵV^2 , where V defines the observed range and ϵ represents the displacement of the origin from the peak (in units of v). If, for example, we choose V=0.5 and keep $\epsilon \leq 0.02$, the systematic error in the computed peak will be about 0.1 percent of the line width.

For an asymmetric line there will be a systematic error even if the range is fortuitously centered about the true peak. Based on the model of eq (2.10), this turns out to be $0.6 \ sV^2$ (in units of v). Thus for V=0.5and s=0.05, the systematic error is about 0.4 percent of the line width. Thus an appreciable asymmetry can preclude use of a parabola over an extended range, as might be expected. This result and eq (5.18) as well are in essential agreement with the calculations of Wilson [22].

5.10. Optimization of Parabolic Fit

An effort to optimize the time intervals at each data point for a parabolic fit yields the result [13] that virtually all the time should be divided equally between the two end points. While the proof is somewhat lengthy, the resulting error is easily computed. Let the fitted curve be represented by

$$\hat{g}(v) = 1 - A(v - v_p)^2,$$
 (5.18)

where an approximate value of A has been determined in a preliminary scan. If now readings g_2 and g_1 are recorded at $\pm V$, with a time interval T/2 at each, it follows that

$$g_2 - g_1 = 4AVv_p.$$
 (5.19)

It is clear that the primary factor determining the error in v_p is the small difference $g_2 - g_1$, whose variance is found with the help of eq (2.13) as $2[g(V) + \eta]/I_p\Delta t$. It follows that

$$\sigma_p^2 = \frac{2}{(4AV)^2} \left[\frac{g(V) + \eta}{I_p(T/2)} \right].$$
(5.20)

For a quasi-Lorentzian line with $V \leq 1$, we have $g(V) \approx 1$ and $A \approx 1$; hence for this case

$$\sigma_{xp}/W = \sigma_p/2 \approx (1+\eta)^{1/2}/4V(I_pT)^{1/2}. \qquad (V \ll 1). \quad (5.21)$$

This is a distinct improvement over eq (5.17), which represents the case of equal counting times at many points. However, as V is increased, the coefficient A in eq (5.18) will be decreased, and the possible improvement in accuracy correspondingly diminished. Furthermore, this two-point method assumes the line is exactly symmetrical and provides no internal check on this assumption; this fact would seem to limit its practical application.

5.11. Profile Known a Priori

We now turn to the case where the *exact* form of the profile is known or assumed a priori. The problem then reduces to determining the amplitude, width, and peak position, which may be done by a least squares adjustment.

The present analysis will be restricted to a symmetric line profile, e.g., a Lorentzian; in this case a determination of the peak is, of course, also a determination of the centroid and the median.

Let the given functional form be denoted by f(v). We will assume that the approximate parameters for the line are known from a preliminary scan and that the approximate peak location is used to define the origin of the v-coordinate. In forming the dimensionless variables g and v, let these approximate values I_{p0} and W_0 be employed. The corresponding true values, I_p and W, may be expressed as $I_{p0}(1+\gamma)$ and $W_0(1+\mu)$ respectively. The true line profile will then become

$$g(v) = (1+\gamma)f\left(\frac{v-v_p}{1+\mu}\right),\tag{5.22}$$

where γ , μ , and v_p are all small compared with unity.

The above equation may be linearized by expanding in a Taylor series and neglecting higher order terms with the result

$$\Delta g = g(v) - f(v) \approx f(v) \gamma - v f'(v) \mu - f'(v) v_p. \quad (5.23)$$

The experimental value of Δg_j at the *j*th point is simply the difference between g_j , the observed value, and $f(v_j)$, the quantity obtained by substituting v_j in the given functional form. If the number of points N > 3, there will now be an overdetermined set of linear equations with unknowns γ , μ , and v_p . This set may be solved by the method of least squares (see, for example, Bearden and Thomsen [32]).

The equation thus obtained by differentiation with respect to v_p is

$$-\Sigma_{i}[f_{i}f_{i}'/\sigma_{i}^{2}]\boldsymbol{\gamma} + \Sigma_{i}[v_{i}(f_{i}')^{2}/\sigma_{i}^{2}]\boldsymbol{\mu}$$
$$+\Sigma_{i}[(f_{i}')^{2}/\sigma_{i}^{2}]\boldsymbol{v}_{p} = -\Sigma_{i}f_{i}'\Delta g_{i}/\sigma_{i}^{2}, \qquad (5.24)$$

where $f_i = f(v_i)$ and $f'_i = f'(v_i)$. For a symmetric function f(v) with a range of observation almost symmetric about the peak, the first two sums are negligible, at least for the purpose of an error estimate. In this case eq (5.24) reduces to

$$v_p = -\left[\sum_i f'_i \Delta g_i / \sigma_i^2\right] \left[\sum_i (f'_i)^2 / \sigma_i^2\right]^{-1}.$$
 (5.25)

Since the variance of Δg_i is simply that of g_i , i.e., $\langle \Delta g_i \Delta g_j \rangle = \sigma_i^2 \delta_{ij}$, it follows that

$$\sigma_p^2 = \frac{\sum_i \sum_j [f'_i f'_j / \sigma_i^2 \sigma_j^2] \sigma_i^2 \delta_{ij}}{[\sum_i (f'_i)^2 / \sigma_i^2]^2} = [\sum_i (f'_i)^2 / \sigma_i^2]^{-1}.$$
 (5.26)

This is essentially the same result as obtained by Muller, Hoyt, Klein, and DuMond [18] for a *known* profile (a "composite line profile") with specified amplitude and width; under the symmetry condition assumed here, the same error is obtained with only approximate values for these two parameters.

The variance, σ_i^2 , is obtained from eq (2.13); with the restriction that $\eta \ll g_i$ throughout the range of observation, we may approximate this as

$$1/\sigma_i^2 \approx (I_p \Delta t_i/g_i) [1 - (\eta/g_i)].$$
 (5.27)

Since $f(v) \approx g(v)$, the distinction may now be dropped for the error calculation. Equations (5.26) and (5.27) then give

$$\frac{1}{\sigma_p^2} = I_p \Sigma_i \left[\frac{(g_i')^2}{g_i} - \frac{\eta(g_i')^2}{g_i^2} \right] \Delta t_i.$$
(5.28)

For equal time intervals $\Delta t_i = T/N = T\Delta v/2V$; passing from the sum to the integral thus yields

$$\frac{1}{\sigma_p^2} = \frac{I_p T}{2V} \int_{-V}^{V} \left\{ \frac{[g'(v)]^2}{g(v)} - \eta \left[\frac{g'(v)}{g(v)} \right]^2 \right\} dv.$$
(5.29)

We may now evaluate this integral for the case of a Lorentzian profile, given by eq (2.7), and obtain finally

$$\left(\frac{\sigma_{xp}}{W}\right)_{eq\ \Delta t} = \frac{\sigma_p}{2} = \left(\frac{V}{2I_pT}\right)^{1/2} \left[\frac{V(V^2-1)}{(1+V^2)^2} + \frac{4\eta V}{1+V^2} + (1-4\eta)\ \tan^{-1}V\right]^{-1/2}.$$
(5.30)

Figure 8 shows the resulting errors, plotted as a function of V for various values of η . In all cases the error is large for small values of V, decreases to a minimum near V=1, and rises slowly thereafter. For the range V=1, the error is

$$\sigma_{xp}/W = 0.80 \ (1 + 0.73\eta)/(I_p T)^{1/2}, \qquad (V = 1), \tag{5.31}$$

which is obviously competitive with the optimum values for the centroid and the median.

A similar analysis may be applied to any known symmetric profile. If the profile is qualitatively similar to a Lorentzian, the error should be comparable to the above result. For a Gaussian profile the numerical factor 0.80 is reduced to 0.76. Moderate asymmetry will complicate computation in the least squares adjustment, since it will then usually be necessary to solve three simultaneous equations in γ , μ , and v_p ; however, it should not greatly change the resulting error.

5.12. Optimization of Lorentzian

The sum in eq (5.28) is a linear function of the Δt_i 's; it will obviously be maximized (and the error



FIGURE 8. Statistical error of peak of a Lorentzian profile (form known a priori) as a function of range for various values of background parameter η . Since the profile is symmetric, this also represents the error of the centroid or median.

correspondingly minimized) by dividing substantially all the time between those points for which the coefficient is a maximum. Substitution of the Lorentzian profile function, eq (2.7), and differentiation with respect to v^2 yields

$$\frac{d}{d(v^2)} \left[\frac{4v^2}{(1+v^2)^3} - \frac{4\eta v^2}{(1+v^2)^2} \right] = 0.$$
 (5.32)

With the neglect of second-order terms in η the optimized value for v^2 becomes $(1/2)[1-(3\eta/4)]$ and it follows that

$$x_{\text{opt}} = v_{\text{opt}} W/2 = \pm (0.71 W/2) [1 - (3\eta/8)], \quad (5.33)$$

in agreement with the result of Merrill and DuMond [17].

If time T/2 is spent at each of these two optimized points, the resulting error obtained from eq (5.28) becomes

$$\sigma_{xp}/W = [0.65/(I_pT)^{1/2}][1 + (3\eta/4)], \quad (5.34)$$

again with the neglect of second-order terms in η . The above result represents the lowest statistical error obtained for any case treated in the present paper; however, this method can introduce a serious undetected systematic error if the line profile is slightly asymmetric.

6. Extrapolated Peak

6.1. Midpoint of Single Chord

The error in the midpoint of a single chord is of interest in itself as well as being a starting point for analysis of the extrapolated peak technique. Suppose a smooth curve $\hat{g}(z)$ has been fitted to the data by the

orthogonal polynomial technique described in secs. 5.1 and 5.2. Assume a specified value G and let this be the *true* value of the curve at z_{k1} , i.e., $\tilde{g}(z_{k1}) = G$; let the fitted curve attain this value at $z_{k1} + \delta z_{k1}$, i.e., $\hat{g}(z_{k1} + \delta z_{k1}) = G$. Then it follows from eq (5.10) that

$$\tilde{g}'(z_{k1})\delta z_{k1} + \sum_{n=0}^{M} \delta a_n \phi_n(z_{k1}) \approx 0,$$
 (6.1)

which yields immediately the value of $\partial z_{k1}/\partial a_n$.

Now let $\overline{z_k}$ be the midpoint of a chord drawn at height G, intersecting the fitted curve at $z_1 + \delta z_{k1}$ on the left side of the profile and at $z_2 + \delta z_{k2}$ on the right. Employing eq (6.1) and setting $\tilde{g}' \approx \hat{g}'$ now yields

$$\frac{\partial \overline{z_k}}{\partial a_n} = \frac{\partial}{\partial a_n} \left(\frac{z_{k1} + z_{k2}}{2} \right) = -\frac{1}{2} \left[\frac{\phi_n(z_{k1})}{\hat{g}'(z_{k1})} + \frac{\phi_n(z_{k2})}{\hat{g}'(z_{k2})} \right].$$
(6.2)

For symmetric curves the two terms in the bracket cancel for even n (since the even order orthogonal polynomials then contain *only* even terms) and are equal for odd n. Thus for this case the above result becomes

$$(\partial \overline{z}_k/\partial a_n) = \begin{cases} 0 & (n \text{ even}) \\ -\phi_n(z_k)/\hat{g}'(z_k) & (n \text{ odd}) \end{cases}, \quad (6.3)$$

where z_k denotes *either* end point of the chord.

Combining this with eqs (5.7) and (5.9) now gives

$$\tau_k^2 = \sum_{n=0}^M \left(\frac{\partial v_k}{\partial a_n} \right)^2 \langle (\delta a_n)^2 \rangle$$
$$= \left(\frac{2}{I_p T} \right) \sum_{\substack{n \text{ odd}}}^M V^2 [\phi_n(z_k)/\hat{g}'(z_k)]^2, \qquad (6.4)$$

$$\sigma_{xk}/W = \sigma_k/2 = V/(2I_pT)^{1/2} \left\{ \sum_{n \text{ odd}}^{M} \left[\phi_n(z_k) \right]^2 \right\}^{1/2} / \left| \hat{g}'(z_k) \right|$$
(6.5)

for symmetric line profiles.

This expression was evaluated [13] for a quasi-Lorentzian line with a 6th degree polynomial and a range V=1. It is found to give a minimum for $g(z_k) \approx 0.75$, in reasonable agreement with the result of Bačkovský [24], who used uniform weighting. In this case we have

$$\sigma_{xk}/W = 0.95/(I_pT)^{1/2}, \qquad (g = 0.75).$$
 (6.6)

This accuracy is obviously competitive with the centroid or median under optimum conditions. However, unless the true line profile is *exactly* symmetric, it will define an entirely new feature and will introduce a systematic error if used to approximate the peak.

6.2. Use of Fitted Curve

If we draw a number of chords as described in the above section, it is possible to fit a smooth "bisector curve" through their midpoints with the use of Legendre polynomials and extrapolate this curve to the top of the profile to obtain the peak. This follows a commonly used graphical technique and is shown in figure 1. With the aid of eq (6.3) we may compute the resulting statistical errors.

Such calculations [13], which are somewhat lengthy, show only minor differences when compared with the result of sec. 5.2 for the geometric peak. For chords equally spaced along the ordinate the error seems to be slightly higher. With chords drawn at equally spaced v_k 's along the abscissa, experimental results indicate a slight reduction in statistical error. However, additional sources of systematic error may be introduced by the choice of range in which the chords are constructed, as well as by the polynomial degree of the bisector curve. Hence, while this extrapolation technique is a valuable tool for graphical work, it seems to offer little advantage for computer calculations.

6.3. Use of Raw Data

It is possible to bypass the fitted curve and construct the bisector curve directly from the data points on either side of the line profile. The error analysis [13] of this method is somewhat simpler mathematically than the preceding case and hence permitted a more comprehensive study. With a straight line as the bisector curve, the resulting statistical error is competitive with the geometrical peak. In the case of a parabola, this error is increased by roughly 50 percent. Actually it is very doubtful that even a parabola is of sufficiently high degree to represent the bisector curve of a line profile with moderate asymmetry. Thus, except as a possible alternative technique for almost symmetric lines, this approach appears to offer little advantage.

7. Conclusions

In general our results are in good agreement with prior workers for cases which have been treated previously. The only possible exception seems to be the suggestion of Porteus and Parratt [21] that the use of the centroid involves an unduly large error; their conclusion appears based on consideration of an infinite truncation range rather than the truncated portions which must be used in practice.

While our experimental results on the peak, as reported in sec. 5.4, are in good agreement with theory, further experiments to verify other predictions would be desirable. In this connection it might be helpful to compare the reproducibility of the difference between two wavelengths (e.g., the $K\alpha_{1,2}$ doublet) as determined by different criteria.

Our analysis is not, of course, restricted to x-ray line profiles, but applies to any similar problem where the errors in the ordinates are primarily due to counting statistics (e.g., nuclear spectroscopy and Mössbauer studies). Furthermore, even when a different error law holds, the basic method of optimizing

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counting times, as developed in sec. 3.3, may be of value in suggesting a more efficient data-taking technique. In fact, the possible gain may be greater in other fields than in the x-ray problems which we have analyzed.

All of our results may be expressed in the form

$$\sigma_x / W = F / (I_p T)^{1/2}, \tag{7.1}$$

where F is a dimensionless factor of the order of unity. Values for a few representative cases are listed in table 3. (While standard deviations are tabulated, error distributions are normal; hence probable errors can be immediately obtained by multiplying by 0.67.)

 TABLE 3. Statistical errors of wavelength features determined by various methods (zero background).

 σ represents standard deviation, W the full width of the profile at half intensity, I_p the peak intensity, and T the total counting time. The range is specified by the dimensionless parameter V = 2X/W, where $-X \le x \le X$.

Case	Truncation range V	$F = (\sigma/W) (I_p T)^{1/2}$	
a. Lorentzian Profile known a priori Peak, centroid, and median	0.71 *1.00 *1.0 6.0 *1.2 6.0	Equal times 0.81 0.81 2.11 0.88 1.49	<i>Opt.</i> <i>times</i> 0.65 0.73 2.05 0.88 1.28
Peak—6th degree polynomial fit Peak—parabolic fit	1.0 0.32	1.67 1.35	$\approx 1.67 \\ 0.82$

*Optimized range for equal counting times.

Obviously it will require the order of 10^6 counts to define a wavelength to within 0.1 percent of the line width. It is also clear that optimization of time intervals can produce only a rather limited improvement in accuracy.

If the line profile is known a priori, it is usually advantageous to make use of this knowledge in calculating the wavelength; e.g., a Lorentzian can be fitted by this method with $F \approx 0.8$. For the Lorentzian or any other symmetric profile known a priori, all three wavelength criteria coincide and any method of locating one locates all. Hence their errors must, of course, be identical. For any known profile of moderate asymmetry the errors should be identical if the width is specified a priori and roughly equal when the width is an adjustable parameter.

In the general case, where the profile form is not known a priori, we may fit a smooth curve to the data by the orthogonal polynomial technique and compute the peak from the fitted curve. (The extrapolation or chord method is a useful graphical technique, but offers no particular advantage in numerical computation, where it can indeed introduce additional systematic error.) With the total counts of the order of 10⁶, a 6th degree polynomial is often satisfactory for the range between the half intensity points (i.e., V=1); resulting values of F range from about 1.6 to 2.1.

We may obtain somewhat lower errors, with a minimum of computational effort, by fitting a parabola over a limited range near the peak. However, extreme caution is necessary when even small asymmetries

are involved. If the number of counts is substantially lower (~ 10^4), or if the curve is more nearly Gaussian in shape, a 4th degree polynomial may be satisfactory over the range V=1, which will give $F \approx 0.9$.

In many cases, adoption of the centroid or median would promise a reduction in statistical error; these criteria can, in fact, be determined to almost the same precision for a quasi-Lorentzian profile as for a true Lorentzian, known a priori. The reduced error is obtained only for a truncated portion with a range $V \sim 1$. Of course, adoption of either criterion would result in new wavelengths, which would frequently differ significantly from the peak values now in general use.

Definition of wavelength in terms of an arbitrarily defined truncation interval appears lacking in fundamental physical significance. Hence it may seem preferable to attempt to approximate the "true centroid" of the entire profile $(V=\infty)$, as done by some crystallographers, or the true median. In this connection, the median has one obvious advantage, viz, it is well defined mathematically. By contrast the centroid of a quasi-Lorentzian curve involves a logarithmically divergent integral. If the tails are sufficiently symmetric, it may be defined by using symmetric truncation limits in the limiting process; otherwise the true centroid simply does not exist mathematically. In any case, when large truncation limits are used, the statistical error may equal or exceed that for the peak of a 6th degree polynomial.

A linear variation in background will cause a systematic error, about twice as great for the centroid and median as for the peak. (Constant background merely produces an increase in statistical error, which is roughly comparable for all three criteria.) An unresolved satellite may also cause a systematic error. With the range $V \sim 1$, the maximum errors from this source for the centroid or median are again about twice that of the peak. On the other hand, the peak is uniquely subject to an additional systematic error due to the degree of the polynomial used to approximate the observed profile; in some cases this may be of the same order as the statistical error.

We wish to reemphasize that the present study has ignored any errors in correcting for instrumental effects, as stated in Assumption C of section 2.1. In γ -ray spectroscopy and in x-ray crystallography these corrections may be much greater than the natural line widths. In such cases the statistical error calculations will still give the errors for the respective features of the *observed* experimental profiles, but these may be completely overshadowed by systematic errors in instrumental corrections. Under these circumstances, statistical counting errors are not particularly relevant in the choice of a wavelength criterion.

Even where instrumental corrections are small, as in the case of x-ray spectroscopy, the present error analysis is somewhat inconclusive in indicating a clear choice among the three wavelength criteria considered. Simplicity and historical precedent clearly favor retention of the peak. It seems doubtful that the limited statistical error reduction attainable in some cases by abandoning the peak, seldom greater than a factor of two, is sufficient incentive to warrant a new wavelength definition which would alter many presently tabulated values.

Before reaching a final decision, it would be highly desirable to know how closely each criterion is associated with the term values for the various energy levels. This problem might be attacked by either a theoretical or an experimental approach.

In our present state of knowledge, we recommend that the use of the peak to define x-ray wavelength be continued. We further recommend that the geometric peak method be used in preference to extrapolation techniques.

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